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		Application Number	
		Filing Date	
		First Named Inventor	Olgica Bakajin et al
		Group Art Unit	
Examiner Name			
Sheet	of	Attorney Docket Number TL-11046	

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			
		BENJAMIN MESSER et al	Microchannel Networks for Nanowire Patterning	J. Am. Chem. Soc. 2000/22, 10232-10333	
		X.Y. ZHANG et al	Template synthesis of High-Density Carbon Nanotube Arrays	Journal of Crystal Growth 233 (2001) 306-310	
km		JIAN CHEN et al	Room-Temperature Assembly of Directional Carbon Nanotube Strings	J. Am. Chem. Soc. Vol. 124; No. 5 2002 pgs. 758-759	
		Y.C. SUI et al	Synthesis of Multi Branched Carbon Nanotubes in Porous Anodic Aluminum Oxide Template	Carbon 39 (2001) 1709-1715	
		JIAN CHEN et al	Room-Temperature Assembly of Directional Carbon Nanotube Strings	Advanced Technologies Group, Zyvcx Corporation JACS Communications	1-11-02
		TAKASHI, KYOTANI ET AL	Synthesis of carbon nanotube composites in nanochannels of an anodic aluminum oxide film	Inst. Chem. Reaction Sci., Tohoku University, Japan Bulletin of the Chem. Soc. Of Japan (1999) 72,(9), 1957-1970	
		TAKASHI, KYOTANI	Preparation of Ultrafine Carbon Tubes in Nanochannels of an Anodic Aluminum Oxide Film	Chem. Mater., 1996, 8, 2109-2113	
		J.LI, C. PAPADOPOULOS ET AL	Highly-ordered Nanotube Arrays for Electronics applications	Applied Physics Letters vol. 75 Number 3 July 19, 1999	

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U.S. PATENT DOCUMENTS						
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		Number	Kind Code ² (if known)			
		6110247		Birmingham et al	08-29-2000	
		6359288	B1	Ying et al	03/19/2002	
		6203814	B1	Fisher et al	03-20-2001	

FOREIGN PATENT DOCUMENTS							
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		WO	01/63273	A2	Noca, Flavio et al	08-30-2001	
		WO	97/38312		Khoury, Simon	10-16-1997	
		WO	02/49762	A2	Lange, Frederick et al	06-27-2002	

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